

FORM PTO-1449

LIST OF PATENTS AND APPLICANT'S INFORMATION DISCLOSURE STATEMENT

ATTORNEY DOCKET NO.: 31090-CON

SERIAL NO.: NOT YET ASSIGNED

FILING DATE: HERewith

APPLICANT: AMMAR ET AL.

GROUP:

REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

EXAMINER INITIALS		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING IF APPROPRIATE
AL	AA	4,712,078	12/08/87	Slobodnik, Jr. et al.	331	99	
AL	AB	4,763,084	08/09/88	Pavio, Jr. et al.	331	56	
AL	AC	4,835,498	05/30/89	Rouger et al.	333	205	
AL	AD	4,887,052	12/12/89	Murakami et al.	331	96	
AL	AE	5,233,319	08/03/93	Mizan et al.	333	219.1	
AL	AF	5,414,741	05/09/95	Johnson	375	376	
AL	AG	5,818,305	10/06/98	Jeon	331	47	
AL	AH	5,834,981	11/10/98	Trier et al.	331	99	
AL	AI	5,940,457	08/17/99	Dreifuss et al.	375	376	
AL	AJ	6,011,446	01/04/00	Woods	331	185	
AL	AK	6,161,003	12/12/00	Lo Curto et al.	455	260	
AL	AL	6,362,708	03/26/02	Woods	333	234	
AL	AM	6,384,691	05/07/02	Sokolov	331	76	
AL	AN	2002/0097100	07/25/02	Woods et al.	331	99	
AL	AO	5,768,693	06/16/98	Wong	455	116	
AL	AR	6,150,890	11/21/00	Damgaard et al.	331	14	
AL	AS	6,188,296	02/13/01	Nibe et al.	331	117 D	

OTHER ART

(Including Author, Title, Date, Pertinent Pages, etc.)

AL	AI	Patent Abstracts of Japan, Vol. 1998, No. 13, November 30, 1998, and JP 10 224217, August 21, 1998.
AL	AJ	Patent Abstracts of Japan, Vol. 007 No. 204, September 9, 1983, and JP 58 101531, June 16, 1983.
AL	AK	Borst, K. et al.; "Low Noise Synthesized Microwave Local Oscillator For High Capacity Digital Radio Systems Using a Dielectric Resonator and a Saw Reference," Proceedings of the European Microwave Conference, September 1989, pp. 555-560.
AL	AL	Khanna, A.P.S. et al.; "A Highly-Stable 36 GHz GaAs FET DRO With Phase-Lock Capability," Microwave Journal, Vol. 32, No. 7, July 1, 1989, pp. 117-118, 120, 122.
AL	AM	Ishii, K. et al.; "An On-Board 47-GHz Phase-Locked Oscillator Using FET Gate Bias Control For Low Phase Noise," Proceedings of the 23rd European Microwave Conference, September 1993, pp. 767-769.
AL	AN	Brumbi, D.; "Low Power FMCW Radar System for Level Gaging," Microwave Symposium Digest, 2000 IEEE MTT-S International, June 2000, pp. 1559-1562.

EXAMINER:

DATE CONSIDERED:

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; * Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.